

NAOMI Cephalometric Sensor





Just by adding the sensor on your existing x-ray machine.

No major modifications or special constructions necessary (both with cassette/drum types)



Only 2 seconds to display the acquired image.

Specifications

Acquisition Method	Csi scintillator (with FOP, noise reduction)
Sensor structure	TDI-CCD sensor
Active imaging area	PA position: 220 x 210 mm / LA position: 220 x 254 mm
Pixel size	192×192μm (48×48μm)
Resolutions	PA positoin: 1152 x 1100 pixels
Grayscale	14bits
Formats	DICOM / BMP / JPEG / PNG / GIF
Interface	USB2.0
Power	AC100V 50 / 60Hz
Operation system	Windows 7/8/8.1 (not compatible with Apple MacOS)
Image acquisition time	Approx. 2 sec. from acquisition to display (upto the computer specifications)
Features with the imaging software	Acquisition, saving, and display / Printing / Sharpness effect / Zoom in & out / Brightness and contrast adjustment / Gamma adjustment / Negative-positive switchover / Rotation / Measurment and notes / Multiwindow displays
Availability	Only in Japan

*Product designs, specifications or features may be changed without a prior notice.